

Search Notes

Application/Control No.

10/608,712

Examiner

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Applicant(s)/Patent under
Reexamination

SUYAMA, AKIHIKO

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	59.23	5/29/2007 <i>updated on 11/9/08</i>	VP <i>vp</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB) 369 (text search only see search history printout).	01/09/2008	VP